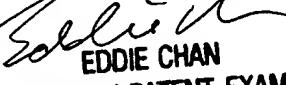


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/972,284	CHILTON, KENDELL A.
	Examiner	Art Unit
	David J. Huisman	2183

ISSUE CLASSIFICATION					
ORIGINAL		CROSS REFERENCE(S)			
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)		
712	34	712	38	225	
INTERNATIONAL CLASSIFICATION		711	118	113	158
g	0	6	F	9/30	
g	0	6	F	12/00	
			/		
			/		
			/		
 David J. Huisman 2-14-06 (Assistant Examiner) (Date)			 Eddie Chan <b>SUPERVISORY PATENT EXAMINER</b> <b>TECHNOLOGY CENTER 2100</b> 2/17/06 (Primary Examiner) (Date)		
Total Claims Allowed: 33					
 Legal Instruments Examiner 2/23/06 (Date)			O.G. Print Claim(s) 1		O.G. Print Fig. 1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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12	9		39	69	99	129	159
13	10		40	70	100	130	160
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